

Notice of References Cited	Application/Control No. 10/738,322	Applicant(s)/Patent Under Reexamination FASTOW ET AL	
	Examiner E Wojciechowicz	Art Unit 2815	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,143,610	11-2000	Wen et al	438/275
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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